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Ion Beam Modification of the Structure and Properties of Hexagonal Boron Nitride

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Abstract content
 (Max 300 words)

Cubic boron nitride (c-BN) nanocrystals have been produced by boron ion implantation of hexagonal boron nitride (h-BN) at various fluences and implantation energies. The optimum fluence was found to be 5x10¹⁴ions/cm<sup>2</sup at 150 keV. The presence of these nanoparticles was investigated using glazing angle XRD (GIXRD) and Fourier Transform Infrared Spectroscopy (FTIR).

Glazing angle XRD pattern after implantation exhibited c-BN diffraction peaks with high intensity at the glazing angle of 3^o whose penetration depth corresponded to the implantation depth. After implantation, Fourier transfore Infrared spectroscopy indicated a peak at 1090 cm⁻¹ which corresponded to the vibrational mode for nc-BN.

Apply to be
 considered for a student
 award (Yes / No)?

Yes

Level for award
 (Hons, MSc,
 PhD)?

PhD

Main supervisor (name and email)
and his / her institution

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Would you like to
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Yes

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